

MVR0402-240E015

1. Electrical Specification

1-1 Test condition

Varistor voltage	In = 1 mA DC
Leakage current	Vdc = 24V DC
Maximum clamping voltage	lc = 1 A
Rated peak single pulse transient current	8 / 20 μ s waveform, +/- each 1 time induce
Capacitance	10/1000 μs waveform
Insulation resistance after reflow soldering	f = 1MHz, Vrms = 0.5 V
	Soldering paste : Tamura (Japan) RMA-20-21L
	Stencil : SUS, 120 m thickness
Reflow soldering condition	Pad size : 0.5 (Width) x 0.6 (Length)
	0.5 (Distance between pads)
	Soldering profile : 260 ± 5 °C, 5 sec.

1-2 Electrical specification

Maximum allowable continuous DC voltage	24	V	
trigger voltage / Varistor voltage / breakdown voltage	150	V	
Maximum clamping voltage	35	V	Maximum
Rated peak single pulse transient current	1	А	Maximum
Nonlinearity coefficient	> 12		
Leakage current at continuous DC voltage	< 0.1	μA	
Response time	< 0.5	ns	
Varistor voltage temperature coefficient	< 0.05	%/℃	
Capacitance measured at 1MHz	0.15	pF	Typical
Capacitance tolerance	-50 to +50	%	
Insulation resistance after reflow soldering on PCB	> 10	MΩ	
Operating ambient temperature	-55 to +125	$^{\circ}\!\mathrm{C}$	
Storage temperature	-55 to +125	°C	



1-3 Reliability testing procedures

Reliability parameter	Test	Test methods and remarks	Test requirement
Pulse current capability	Imax	IEC 1051-1, Test 4.5.	d Vn /Vn \leq 10%
	8/20 µs	10 pulses in the same direction at 2 pulses per minute at maximum peak current	no visible damage
Electrostatic discharge	ESD	<u>IEC 1000-4-2</u>	d Vn /Vn \leq 10%
capability	C=150 pF, R=330 Ω	Each 10 times in positive/negative direction in 10 sec at 8KV contact discharge (Level 4)	no visible damage
Environmenta	Thermal shock	<u>IEC 68-2-14</u>	d $ Vn /Vn \le$ 5%
l reliability		Condition for 1 cycle Step 1 : Min. –40 ℃, 30 ± 3 min. Step 2 : Max. +125 ℃, 30 ± 3 min.	no visible damage
		Number of cycles: 30 times	
	Low temperature	<u>IEC 68-2-1</u>	d $ Vn /Vn \le$ 5%
		Place the chip at -40 ± 5 °C for $1000\pm$ 12hrs. Remove and place for $24\pm$ 2hrs at room temp. condition, then measure	no visible damage
	High temperature	<u>IEC 68-2-2</u>	d $ Vn /Vn \le$ 5%
		Place the chip at 125 ± 5 °C for $1000\pm$ 24hrs. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	no visible damage
	Heat resistance	<u>IEC 68-2-3</u>	d Vn /Vn ≤ 5%
		Apply the rated voltage for 1000 ± 48 hrs at 85 ± 3 °C. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	no visible damage
	Humidity	<u>IEC 68-2-30</u>	d $ Vn /Vn \le 10\%$
	resistance	Place the chip at $40 \pm 2^{\circ}$ and 90 to 95% humidity for 1000 ± 24 hrs. Remove and place for 24 ± 2 hrs at room temp. condition, then measure	no visible damage
	Pressure cooker	Place the chip at 2 atm, 120 $^\circ\!\!\mathbb{C}$, 85%RH	d Vn /Vn ≤ 10%
	test	for 60 hrs. Remove and place for $24 \pm$ 2hrs at room temp. condition, then measure	no visible damage
	Operating life	Apply the rated voltage for 1000 ± 48 hrs at 125 ± 3 °C. Remove and place for $24 \pm$ 2 hrs at room temp. condition, then measure	d Vn /Vn≤10% no visible damage

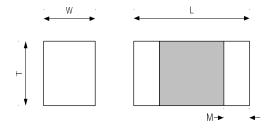


Mechanical Reliability	Solderability	<u>IEC 68-2-58</u> Solder bath method, 230±5℃, 2s	At least 95% of terminal electrode is covered by new solder
	Resistance to	<u>IEC 68-2-58</u>	d Vn /Vn ≤ 5%
soldering heat	Solder bath method, 260±5℃, 10±0.5s, 270±5℃, 3±0.5s	no visible damage	
	Bending strength	<u>IEC 68-2-21</u>	d Vn /Vn ≤ 5%
		Warp:2mm, Speed:0.5mm/sec, Duration: 10sec. The measurement shall be made with board in the bent position	no visible damage
	Adhesive strength	<u>IEC 68-2-22</u>	Strength>10 N
		Applied force on SMD chip by fracture from PCB	no visible damage

2. Material Specification

Body	ZnO based ceramics	
Internal electrode	Silver – Palladium	
External electrode	Silver – Nickel – Tin	
Thickness of Ni/Sn plating layer	Nickel > 1 μ m, Tin > 2 μ m	

3. Dimension Specification



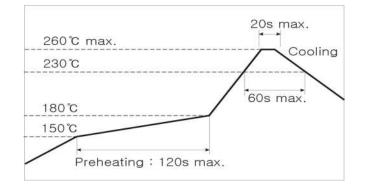
Size	L(mm)	W(mm)	T(mm)	M(mm)
0402	1.0 ± 0.10	0.5 ± 0.10	≤ 0.6	0.20 ± 0.10
0603	1.6±0.15	0.8±0.15	≤ 0.9	0.35 ± 0.10

4. Soldering Recommendations

4-1 Soldering profile

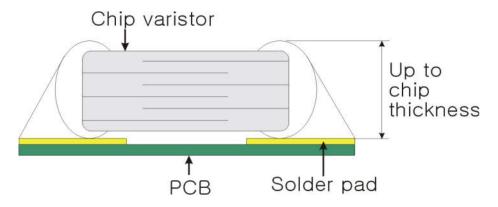


4-1-1 Pb free solder paste



4-1-2 Repair soldering

- Allowable time and temperature for making correction with a soldering iron : 350 \pm 10 $^\circ$ C, 3 sec.
- Optimum solder amount when corrections are made using a soldering iron

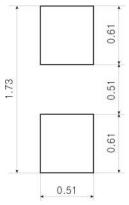


4-2 Soldering guidelines

- Our chip varistors are designed for reflow soldering only. Do not use flow soldering
- Use non-activated flux (CI content 0.2% max.)
- Follow the recommended soldering conditions to avoid varistor damage.



4-3 Solder pad layout



5. Storage condition

- Storage environment must be at an ambient temperature of 25~35 $\,^\circ\!{\rm C}\,$ and an ambient humidity of 40~60 % RH
- Chip varistors can experience degradation of termination solderability when subjected to high temperature of humidity, or if exposed to sulfur or chlorine gases.
- Avoid mechanical shock (ex. Falling) to the chip varistor to prevent mechanical cracking inside of the ceramic dielectric due to its own weight.
- Use chips within 6 months.

If 6 months of more have elapsed, check solderability before use.-

6. Description about package label

Type : MVR0402-240E015

- MVR: Series name
- 0402 : Chip size -0402 (1.0 x 0.5 mm) size
- 240 : Maximum continuous working voltage 24Vdc
- E : Product function E for ESD
- 015: Capacitance value means 0.15pF

Qunatity : 10,000 pcs

- Quantity of shipping chip varistor

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